

MOSFETs Silicon P-Channel MOS (U-MOSVI)

SSM6J505NU

1. Applications

· Power Management Switches

2. Features

- (1) 1.2 V gate drive voltage.
- (2) Low drain-source on-resistance

 $: R_{DS(ON)} = 61 \text{ m}\Omega \text{ (max) } (@V_{GS} = -1.2 \text{ V})$

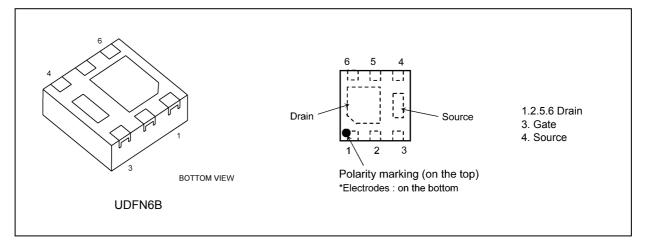
 $R_{\mathrm{DS(ON)}} = 30 \ \mathrm{m}\Omega \ (\mathrm{max}) \ (@V_{\mathrm{GS}} = -1.5 \ \mathrm{V})$

 $R_{DS(ON)} = 21 \text{ m}\Omega \text{ (max) (@V_{GS} = -1.8 V)}$

 $R_{DS(ON)} = 16 \text{ m}\Omega \text{ (max) } (@V_{GS} = -2.5 \text{ V})$

 $R_{\mathrm{DS(ON)}} = 12 \ \mathrm{m}\Omega \ (\mathrm{max}) \ (@V_{\mathrm{GS}} = \text{-}4.5 \ \mathrm{V})$

3. Packaging and Pin Assignment



Start of commercial production



4. Absolute Maximum Ratings (Note) (Unless otherwise specified, Ta = 25°C)

	Characteristics		Symbol	Rating	Unit
Drain-source voltage			V _{DSS}	-12	V
Gate-source voltage			V _{GSS}	±6	
Drain current (DC)		(Note 1)	I _D	-12	Α
Drain current (pulsed)		(Note 1),(Note 2)	I _{DP}	-30	
Power dissipation		(Note 3)	P _D	1.25	W
Power dissipation	t ≤ 10 s	(Note 3)	P _D	2.5	W
Channel temperature			T _{ch}	150	°C
Storage temperature			T _{stg}	-55 to 150	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

- Note 1: Ensure that the channel temperature does not exceed 150°C.
- Note 2: Pulse width (PW) \leq 10 ms, duty \leq 1%
- Note 3: Device mounted on an FR4 board.

(25.4 mm \times 25.4 mm \times 1.6 mm, Cu Pad : 645 mm²)

Note: The MOSFETs in this device are sensitive to electrostatic discharge. When handling this device, the worktables, operators, soldering irons and other objects should be protected against anti-static discharge.

Note: The channel-to-ambient thermal resistance, R_{th(ch-a)}, and the drain power dissipation, P_D, vary according to the board material, board area, board thickness and pad area. When using this device, be sure to take heat dissipation fully into account.

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5. Electrical Characteristics

5.1. Static Characteristics (T_a = 25°C unless otherwise specified)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS} = \pm 6 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±1	μА
Drain cut-off current		I _{DSS}	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}$	_	_	-1	
Drain-source breakdown voltage		V _{(BR)DSS}	$I_D = -1 \text{ mA}, V_{GS} = 0 \text{ V}$	-12	_	_	V
Drain-source breakdown voltage	(Note 1)	V _{(BR)DSX}	$I_D = -1 \text{ mA}, V_{GS} = 5 \text{ V}$	-7	_	_	
Gate threshold voltage	(Note 2)	V_{th}	$V_{DS} = -3 \text{ V}, I_{D} = -1 \text{ mA}$	-0.3	_	-1.0	
Drain-source on-resistance	(Note 3)	R _{DS(ON)}	I _D = -4.0 A, V _{GS} = -4.5 V	_	9	12	mΩ
			$I_D = -4.0 \text{ A}, V_{GS} = -2.5 \text{ V}$	_	11	16	
			I _D = -3.5 A, V _{GS} = -1.8 V	_	13	21	
			I _D = -1.5 A, V _{GS} = -1.5 V	_	14	30	
			I _D = -0.5 A, V _{GS} = -1.2 V	_	18	61	
Forward transfer admittance	(Note 3)	Y _{fs}	$V_{DS} = -3 \text{ V}, I_{D} = -2.0 \text{ A}$	12	24	_	S

- Note 1: If a reverse bias is applied between gate and source, this device enters $V_{(BR)DSX}$ mode. Note that the drain-source breakdown voltage is lowered in this mode.
- Note 2: Let V_{th} be the voltage applied between gate and source that causes the drain current (I_D) to below (-1 mA for this device). Then, for normal switching operation, $V_{GS(ON)}$ must be higher than V_{th} , and $V_{GS(OFF)}$ must be lower than V_{th} . This relationship can be expressed as: $V_{GS(OFF)} < V_{th} < V_{GS(ON)}$.

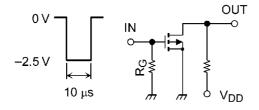
 Take this into consideration when using the device.

Note 3: Pulse measurement.

5.2. Dynamic Characteristics (T_a = 25°C unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Input capacitance	C _{iss}	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V},$	ı	2700		pF
Reverse transfer capacitance	C _{rss}	f = 1 MHz		800		
Output capacitance	Coss		_	800	_	
Switching time (turn-on time)		V_{DD} = -10 V, I_{D} = -1.0 A V_{GS} = 0 to -2.5 V, R_{G} = 4.7 Ω ,		46	1	ns
Switching time (turn-off time)		Duty \leq 1%, Input: t_r , t_f < 5 ns Ground source, See Chapter 5.3	_	420	_	

5.3. Switching Time Test Circuit



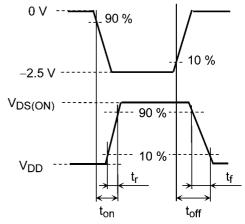


Fig. 5.3.1 Switching Time Test Circuit

Fig. 5.3.2 Input Waveform/Output Waveform



5.4. Gate Charge Characteristics (T_a = 25°C unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Total gate charge (gate-source plus gate-drain)	Q_g	$V_{DD} = -6 \text{ V}, V_{GS} = -4.5 \text{ V},$	_	37.6	_	nC
Gate-source charge 1	Q _{gs1}	I _D = -12 A	_	4.7		
Gate-drain charge	Q _{gd}		_	8.4	_	

5.5. Source-Drain Characteristics (T_a = 25°C unless otherwise specified)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Diode forward voltage	(Note 1)	V_{DSF}	$I_D = 4.0 \text{ A}, V_{GS} = 0 \text{ V}$	_	0.8	1.0	V

Note 1: Pulse measurement.

6. Marking

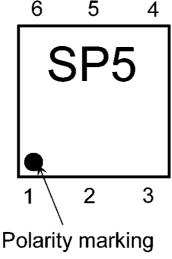
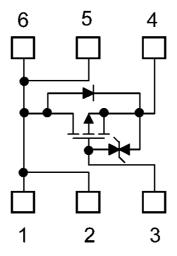


Fig. 6.1 Marking

7. Internal Equivalent Circuit





8. Characteristics Curves (Note)

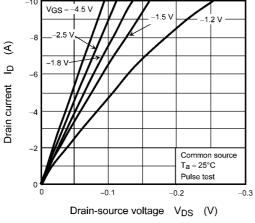


Fig. 8.1 I_D - V_{DS}

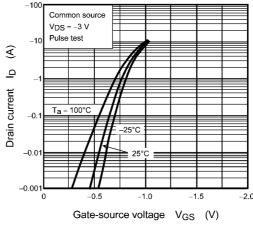


Fig. 8.2 I_D - V_{GS}

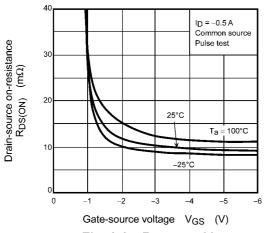


Fig. 8.3 R_{DS(ON)} - V_{GS}

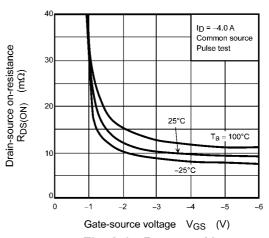


Fig. 8.4 R_{DS(ON)} - V_{GS}

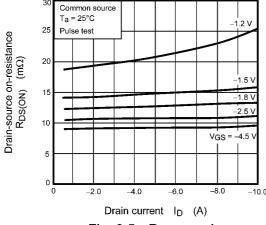


Fig. 8.5 R_{DS(ON)} - I_D

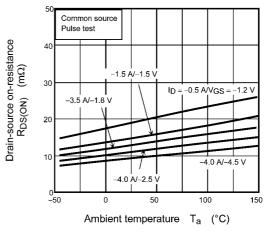


Fig. 8.6 R_{DS(ON)} - T_a



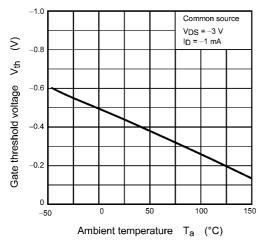


Fig. 8.7 V_{th} - T_a

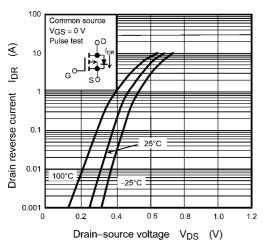
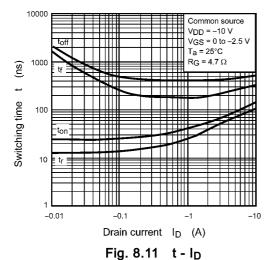


Fig. 8.9 I_{DR} - V_{DS}



Common source

VDS = -3 V

Ta = 25°C

Pulse test

10

0.1

-0.01

Drain current I_D (A)

Fig. 8.8 |Y_{fs}| - I_D

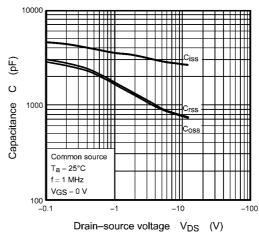


Fig. 8.10 C - V_{DS}

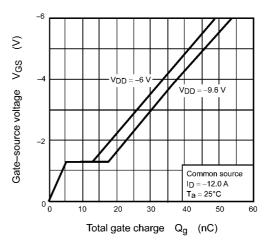


Fig. 8.12 Dynamic Input/Output Characteristics



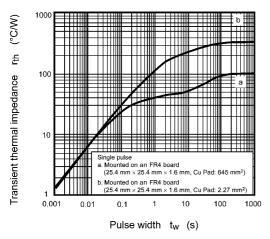


Fig. 8.13 r_{th} - t_w

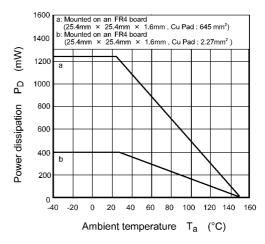


Fig. 8.14 PD - Ta

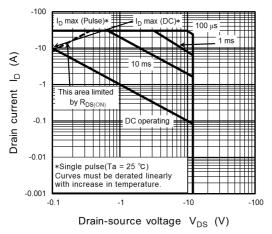


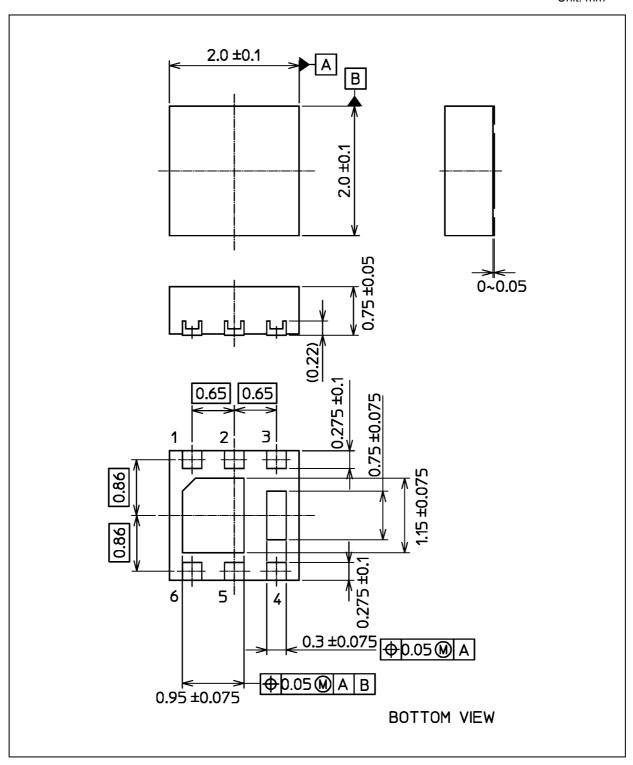
Fig. 8.15 Safe Operating Area

Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.



Package Dimensions

Unit: mm



Weight: 8.5 mg (typ.)

	Package Name(s)				
Nickname: UDFN6B					



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